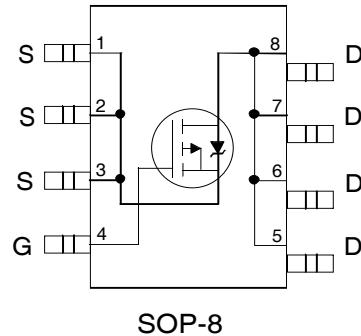


## Features

- $V_{DS} (V) = -55V$
- $R_{DS(ON)} < 40 \text{ m}\Omega$  ( $V_{GS} = -4.5V$ )
- $R_{DS(ON)} < 60 \text{ m}\Omega$  ( $V_{GS} = -2.7V$ )
- Generation V Technology
- Ultra Low On-Resistance
- Surface Mount
- Dynamic dv/dt Rating
- Fast Switching
- Lead-Free



## Description

The SOP-8 has been modified through a customized leadframe for enhanced thermal characteristics and multiple-die capability making it ideal in a variety of power applications. With these improvements, multiple devices can be used in an application with dramatically reduced board space. The package is designed for vapor phase, infrared, or wave soldering techniques. Power dissipation of greater than 0.8W is possible in a typical PCB mount application.

## Absolute Maximum Ratings

	Parameter	Max.	Units
$I_D @ T_A = 25^\circ\text{C}$	10 Sec. Pulsed Drain Current, $V_{GS} @ -4.5V$	-7.7	A
$I_D @ T_A = 25^\circ\text{C}$	Continuous Drain Current, $V_{GS} @ -4.5V$	-6.7	
$I_D @ T_A = 70^\circ\text{C}$	Continuous Drain Current, $V_{GS} @ -4.5V$	-5.4	
$I_{DM}$	Pulsed Drain Current ①	-27	
$P_D @ T_A = 25^\circ\text{C}$	Power Dissipation	2.5	W
	Linear Derating Factor	0.02	W/ $^\circ\text{C}$
$V_{GS}$	Gate-to-Source Voltage	$\pm 12$	V
$dv/dt$	Peak Diode Recovery $dv/dt$ ②	-5.0	V/ns
$T_J, T_{STG}$	Junction and Storage Temperature Range	-55 to + 150	$^\circ\text{C}$

## Thermal Resistance Ratings

	Parameter	Typ.	Max.	Units
$R_{\theta JA}$	Maximum Junction-to-Ambient ④		50	$^\circ\text{C}/\text{W}$

Electrical Characteristics @  $T_J = 25^\circ\text{C}$  (unless otherwise specified)

	Parameter	Min.	Typ.	Max.	Units	Conditions
$V_{(\text{BR})\text{DSS}}$	Drain-to-Source Breakdown Voltage	-20			V	$V_{GS} = 0V, I_D = -250\mu\text{A}$
$\Delta V_{(\text{BR})\text{DSS}/\Delta T_J}$	Breakdown Voltage Temp. Coefficient		-0.012		V/ $^\circ\text{C}$	Reference to $25^\circ\text{C}, I_D = -1\text{mA}$
$R_{DS(\text{ON})}$	Static Drain-to-Source On-Resistance			40	$\text{m}\Omega$	$V_{GS} = -4.5V, I_D = -3.2\text{A}$ ③
				60		$V_{GS} = -2.7V, I_D = -2.7\text{A}$ ③
$V_{GS(\text{th})}$	Gate Threshold Voltage	-0.70			V	$V_{DS} = V_{GS}, I_D = -250\mu\text{A}$
$g_{fs}$	Forward Transconductance	6.8			S	$V_{DS} = -15V, I_D = -3.2\text{A}$
$I_{\text{DSS}}$	Drain-to-Source Leakage Current			-1.0	$\mu\text{A}$	$V_{DS} = -16V, V_{GS} = 0V$
				-25		$V_{DS} = -16V, V_{GS} = 0V, T_J = 125^\circ\text{C}$
$I_{GSS}$	Gate-to-Source Forward Leakage			-100	$\text{nA}$	$V_{GS} = -12V$
	Gate-to-Source Reverse Leakage			100		$V_{GS} = 12V$
$Q_g$	Total Gate Charge			50	$\text{nC}$	$I_D = -3.2\text{A}$
$Q_{gs}$	Gate-to-Source Charge			5.5		$V_{DS} = -16V$
$Q_{gd}$	Gate-to-Drain ("Miller") Charge			21		$V_{GS} = -4.5V$ , See Fig. 6 and 12 ③
$t_{d(on)}$	Turn-On Delay Time			14	$\text{ns}$	$V_{DD} = -10V$ $I_D = -3.2\text{A}$ $R_G = 6.0\Omega$ $R_D = 3.1\Omega$ , See Fig. 10 ③
$t_r$	Rise Time			32		
$t_{d(off)}$	Turn-Off Delay Time			100		
$t$	Fall Time			65		
$L_D$	Internal Drain Inductance			2.5	$\text{nH}$	Between lead tip and center of die contact
$L_S$	Internal Source Inductance			4.0		
$C_{iss}$	Input Capacitance			1500	$\text{pF}$	$V_{GS} = 0V$
$C_{oss}$	Output Capacitance			730		$V_{DS} = -15V$
$C_{rss}$	Reverse Transfer Capacitance			340		$f = 1.0\text{MHz}$ , See Fig. 5

## Source-Drain Ratings and Characteristics

	Parameter	Min.	Typ.	Max.	Units	Conditions
$I_S$	Continuous Source Current (Body Diode)			-3.1	$\text{A}$	MOSFET symbol showing the integral reverse p-n junction diode.
$I_{SM}$	Pulsed Source Current (Body Diode) ①			-27		
$V_{SD}$	Diode Forward Voltage			-1.0	V	$T_J = 25^\circ\text{C}, I_S = -2.0\text{A}, V_{GS} = 0V$ ③
$t_{rr}$	Reverse Recovery Time		69	100	$\text{ns}$	$T_J = 25^\circ\text{C}, I_F = -3.2\text{A}$
$Q_{rr}$	Reverse Recovery Charge		71	110	$\mu\text{C}$	$dI/dt = 100\text{A}/\mu\text{s}$ ③
$t_{on}$	Forward Turn-On Time					Intrinsic turn-on time is negligible (turn-on is dominated by $L_S + L_D$ )

## Notes:

- ① Repetitive rating; pulse width limited by max. junction temperature. ( See fig. 11 )
- ②  $I_{SD} \leq -3.2\text{A}$ ,  $dI/dt \leq -65\text{A}/\mu\text{s}$ ,  $V_{DD} \leq V_{(\text{BR})\text{DSS}}$ ,  $T_J \leq 150^\circ\text{C}$
- ③ Pulse width  $\leq 300\mu\text{s}$ ; duty cycle  $\leq 2\%$ .
- ④ Surface mounted on FR-4 board,  $t \leq 10\text{sec}$ .

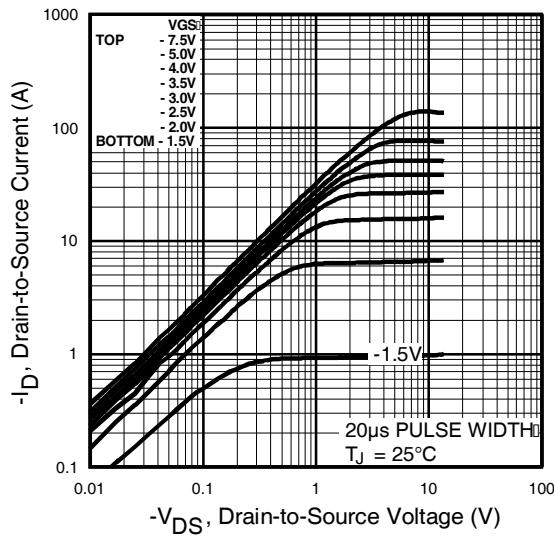


Fig 1. Typical Output Characteristics

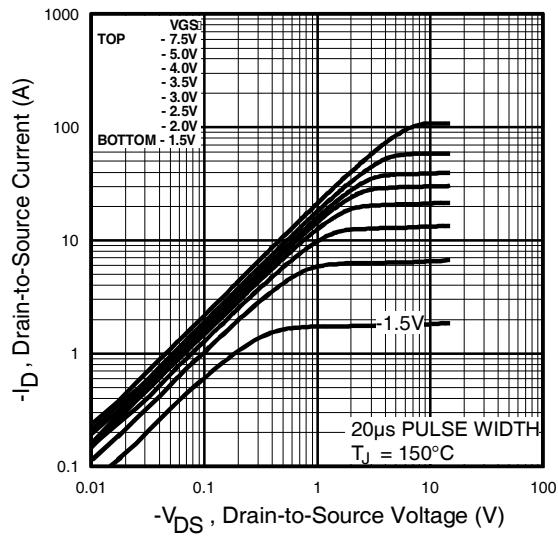


Fig 2. Typical Output Characteristics

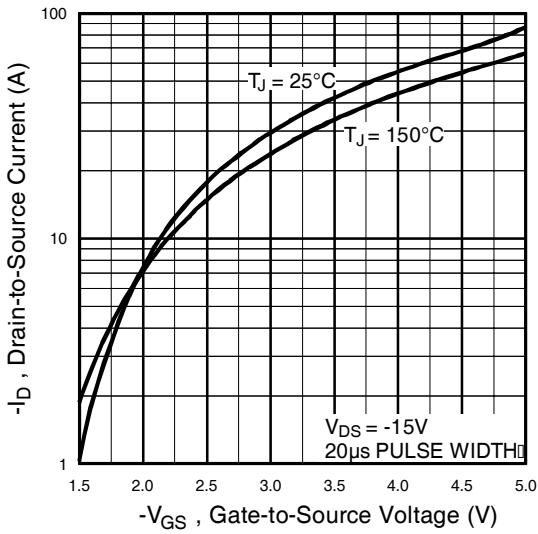


Fig 3. Typical Transfer Characteristics

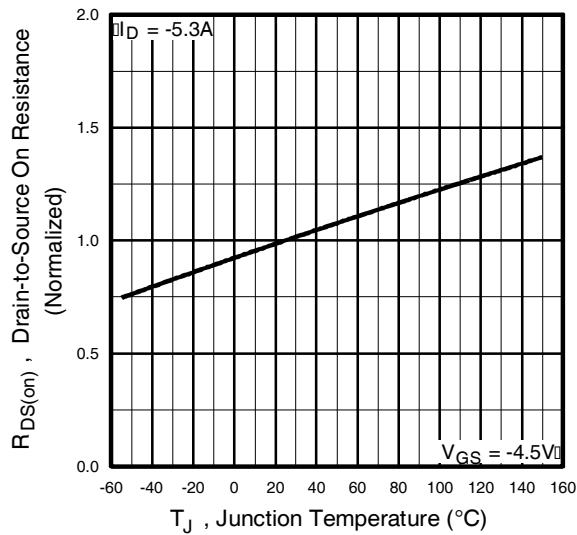
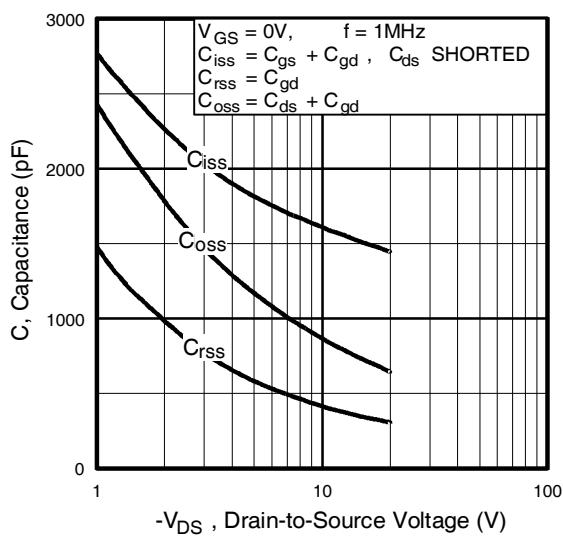
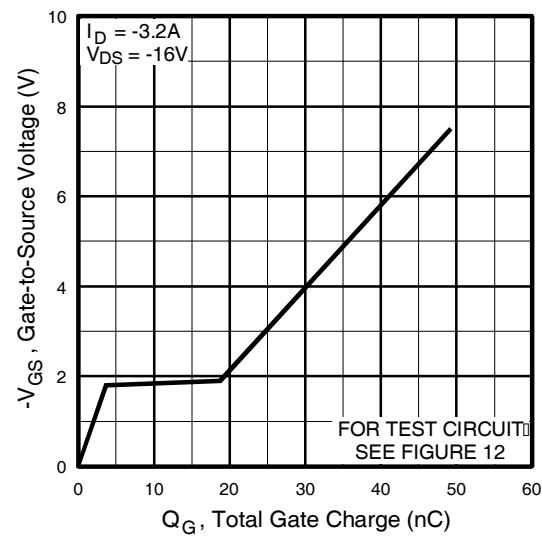


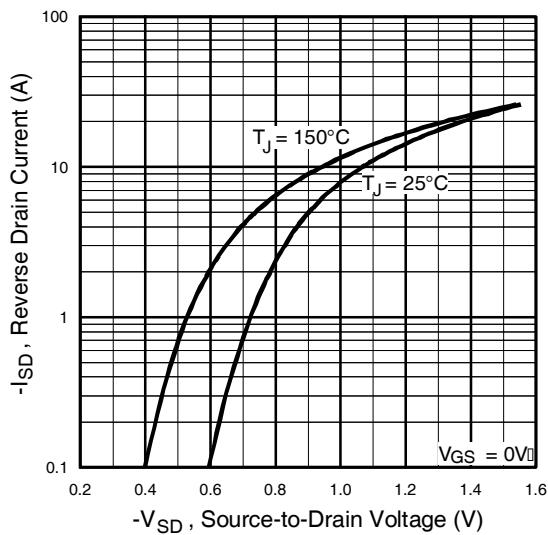
Fig 4. Normalized On-Resistance Vs. Temperature



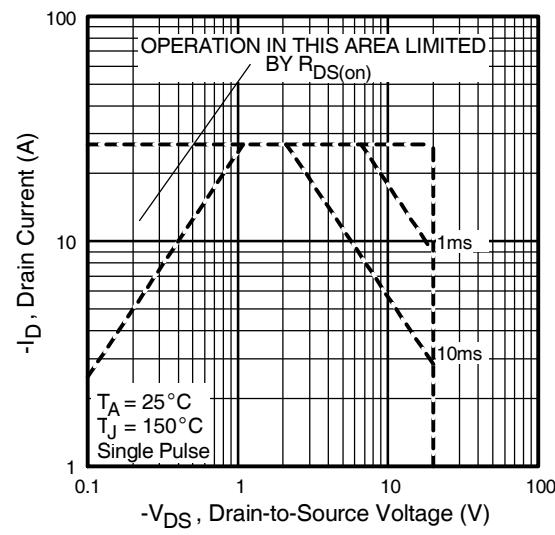
**Fig 5.** Typical Capacitance Vs.  
Drain-to-Source Voltage



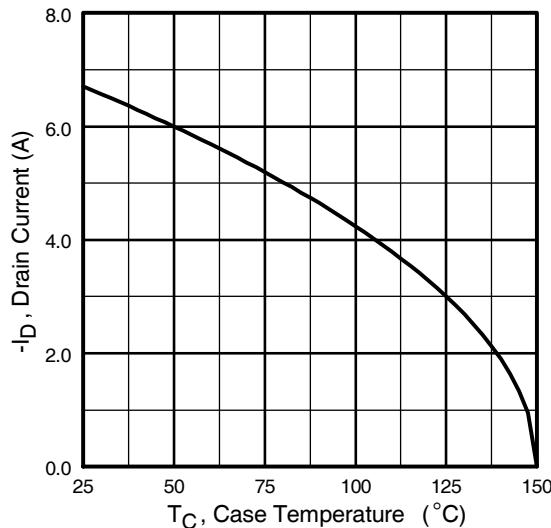
**Fig 6.** Typical Gate Charge Vs.  
Gate-to-Source Voltage



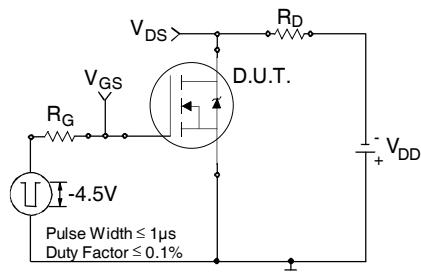
**Fig 7.** Typical Source-Drain Diode  
Forward Voltage



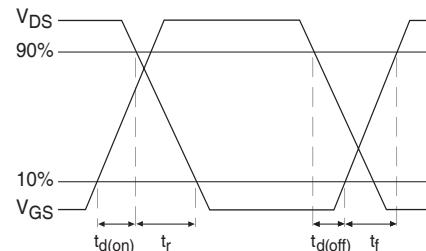
**Fig 8.** Maximum Safe Operating Area



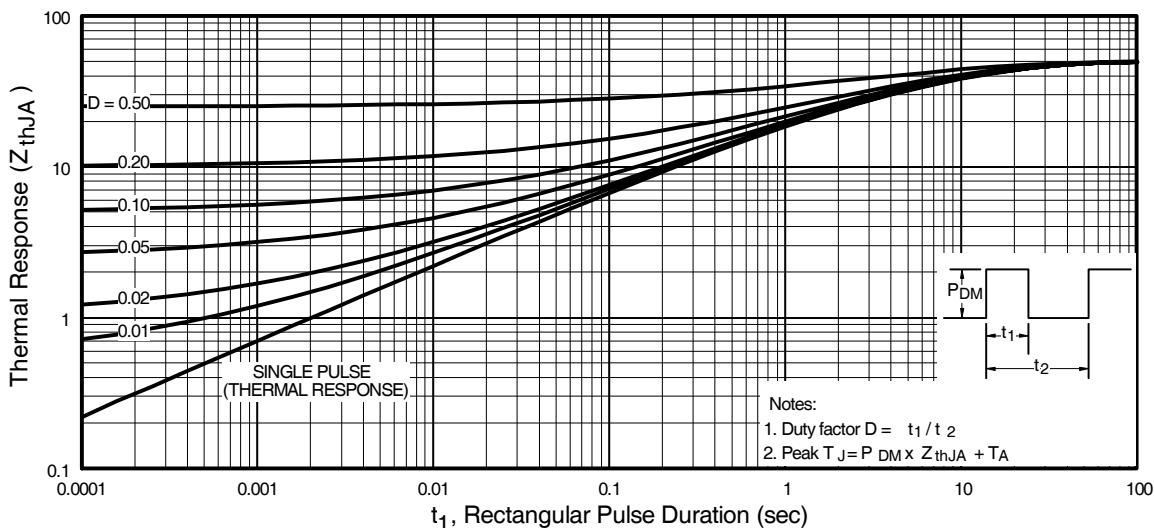
**Fig 9.** Maximum Drain Current Vs.  
Ambient Temperature



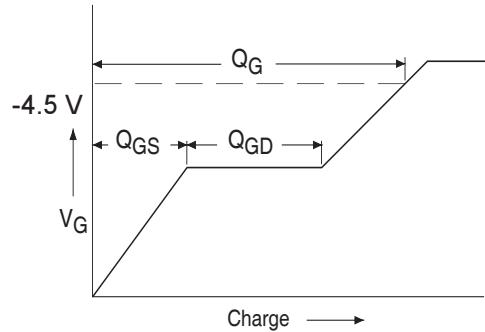
**Fig 10a.** Switching Time Test Circuit



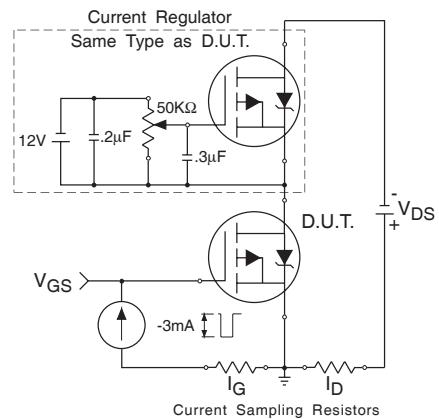
**Fig 10b.** Switching Time Waveforms



**Fig 11.** Maximum Effective Transient Thermal Impedance, Junction-to-Ambient

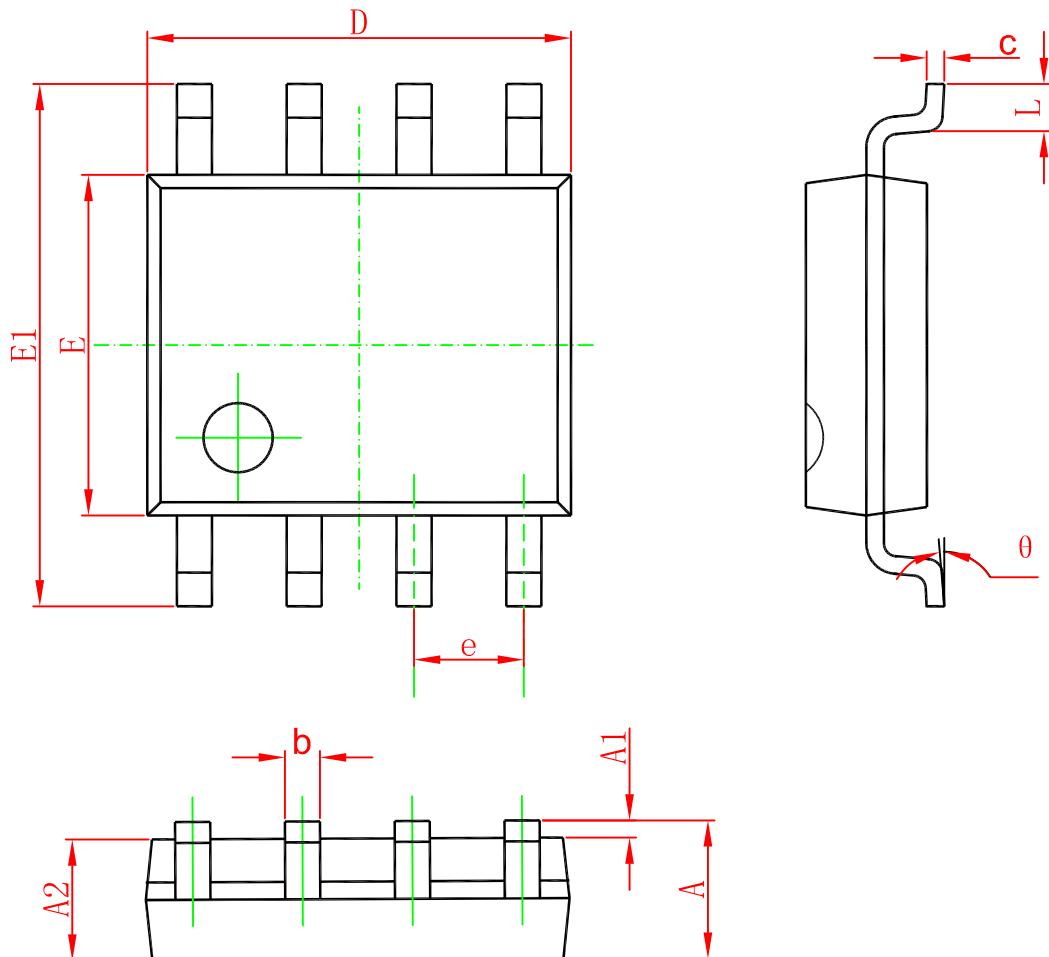


**Fig 12a.** Basic Gate Charge Waveform



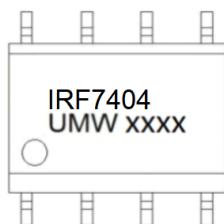
**Fig 12b.** Gate Charge Test Circuit

## SOP-8



Symbol	Dimensions In Millimeters		Dimensions In Inches	
	Min	Max	Min	Max
A	1.350	1.750	0.053	0.069
A1	0.100	0.250	0.004	0.010
A2	1.350	1.550	0.053	0.061
b	0.330	0.510	0.013	0.020
c	0.170	0.250	0.006	0.010
D	4.700	5.100	0.185	0.200
E	3.800	4.000	0.150	0.157
E1	5.800	6.200	0.228	0.244
e	1.270(BSC)		0.050(BSC)	
L	0.400	1.270	0.016	0.050
θ	0°	8°	0°	8°

## Marking



## Ordering information

Order code	Package	Baseqty	Deliverymode
UMW IRF7404TR	SOP-8	3000	Tape and reel